

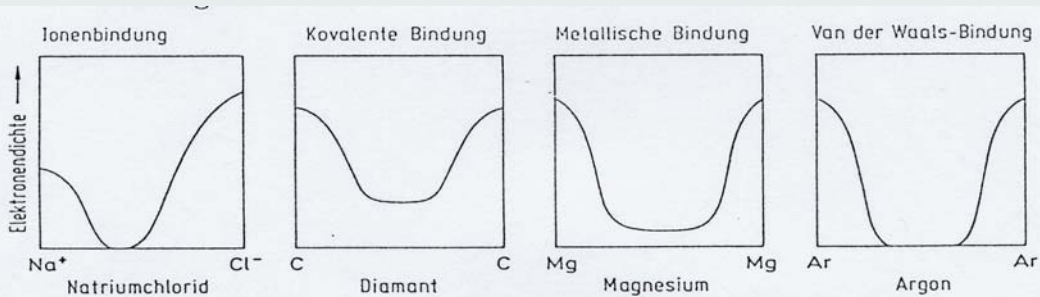
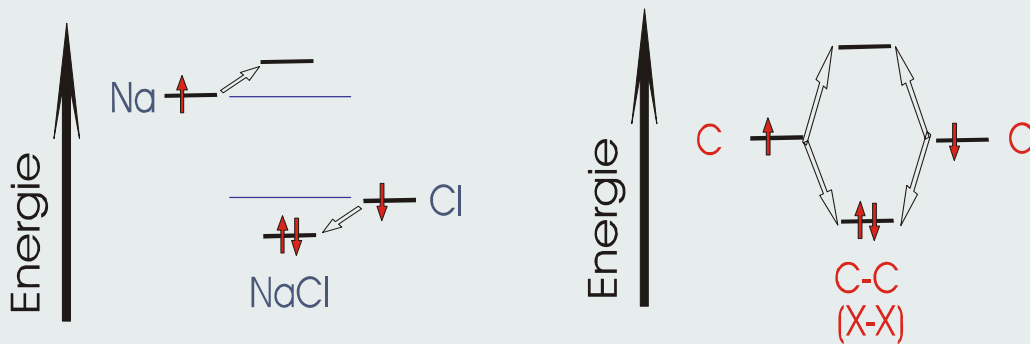
Chemical Bonding

type	Energies	Forces
ionic	$E \sim 1/r$	$F \sim 1/r^2$
covalent	$E \sim 1/r^3$	$F \sim 1/r^4$
van der Waals	$E \sim 1/r^5$	$F \sim 1/r^6$

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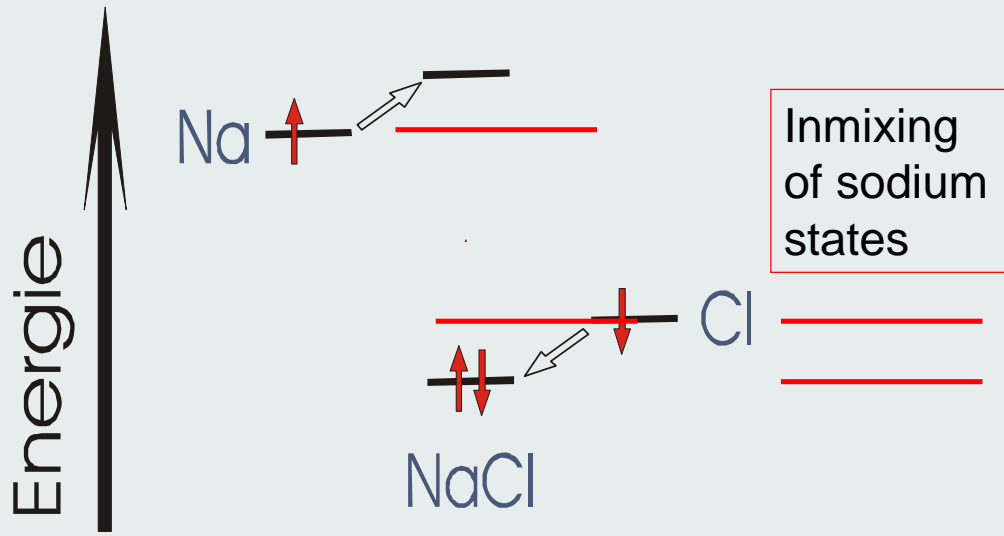
Chemical Bonding



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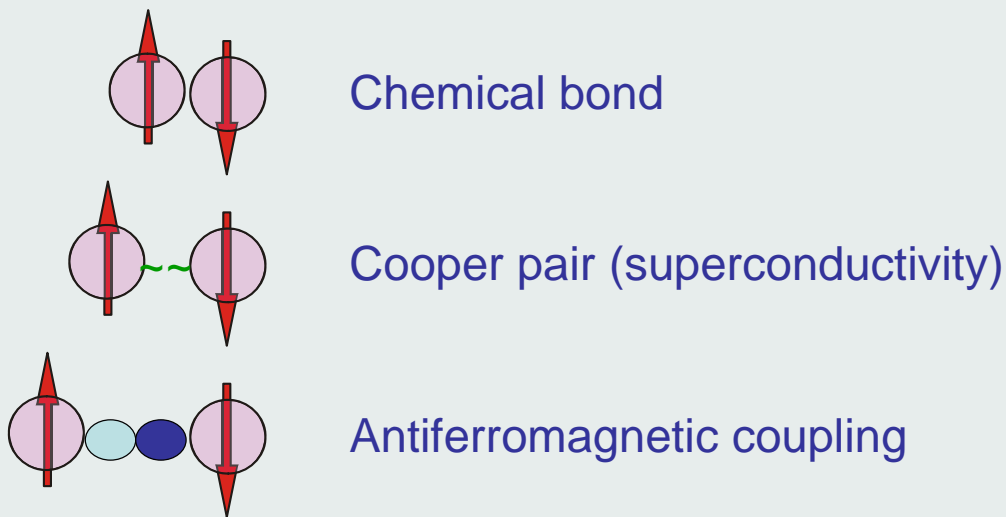
Chemical Bonding



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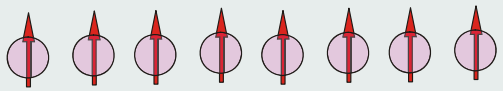
Antiparallel Couplings



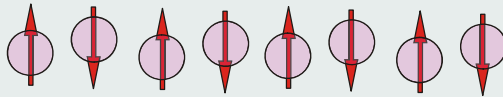
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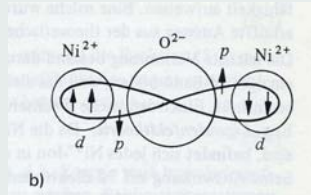
Collective Couplings



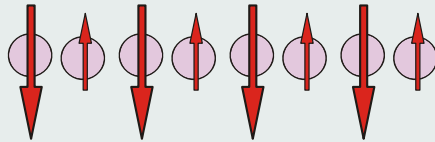
ferro



antiferro

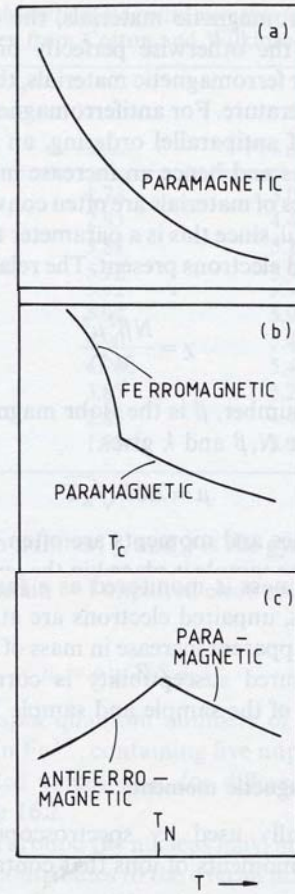


ferri

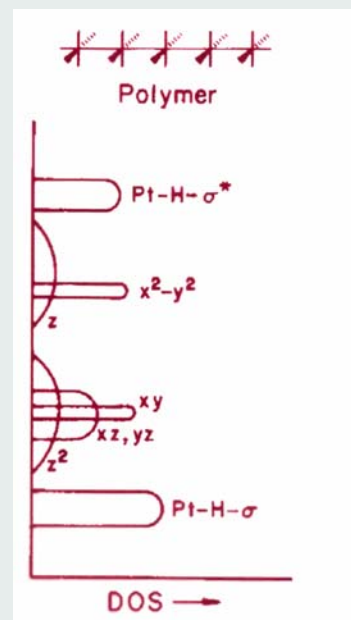
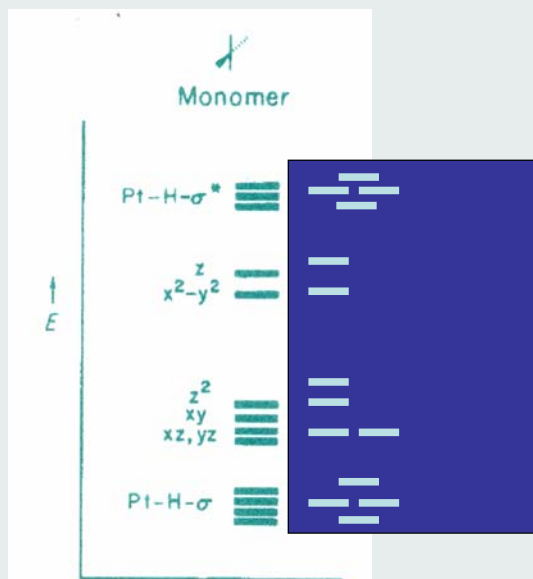


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Molecules and Solids



R. Hoffmann, Solids and Surfaces, VCH, Weinheim 1988

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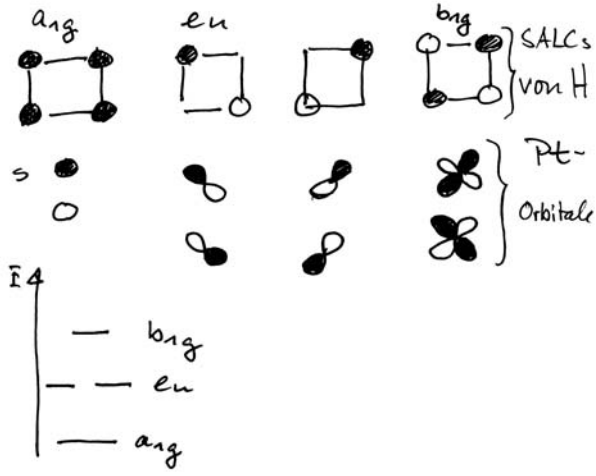
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PtH Bonds



Ermittlung der irreduziblen Darstellungen aus der reduzierten (RD).

	E	$2C_4$	C_2	$2C_2'$	$2C_2''$	i	$2S_4$	σ_h	$2\sigma_v$	$2\sigma_d$
RD: 4	0	0	2	0	0	0	0	4	2	0
a_{1g} : 1	1	1	1	1	1	1	1	1	1	1
e_u : 2	0	-2	0	0	-2	0	0	2	0	0
	-3	1	-1	1	1	-1	1	3	-1	-1
b_{1g} : 1	-1	1	1	-1	1	-1	-1	1	1	-1



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LCAO in Polymers

LCAO approach

$$k=0 \quad \psi_0 = \sum_n e^{i0n} \chi_n = \sum_n \chi_n$$

$$= \chi_0 + \chi_1 + \chi_2 + \chi_3 + \dots$$

$$k=\frac{\pi}{a} \quad \psi_{\frac{\pi}{a}} = \sum_n e^{i\pi n} \chi_n = \sum_n (-1)^n \chi_n$$

$$= \chi_0 - \chi_1 + \chi_2 - \chi_3 + \dots$$

k controls the combination of orbitals (basis functions)
 if $k=0$ all orbitals are unchanged
 if $k=\frac{\pi}{a}$ every other unit cell has inversed orbital signs
 a is the lattice constant (1D problem, chain)

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Nanochemistry UIO

What is k ?

k controls the combination of orbitals (basis functions)
if $k=0$ all orbitals are unchanged
if $k=\pi/a$ every other unit cell has inversed orbital signs
a is the lattice constant (1D problem, chain)

k is also a node counter
as k has a directionality it is always a vector (3D: k_x, k_y, k_z)
if there are n orbitals in the set of one kind,
there are n k vectors from $k=0$ to $k=\pi/a$


$$\pi/a$$


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Nanochemistry UIO

What is k ?

LCAO approach

$$k=0 \quad \psi_0 = \sum_n e^{i0n} \chi_n = \sum_n \chi_n$$
$$= \chi_0 + \chi_1 + \chi_2 + \chi_3 + \dots$$


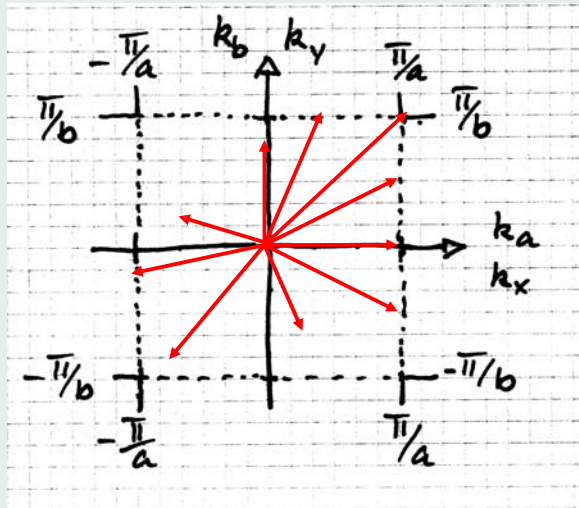
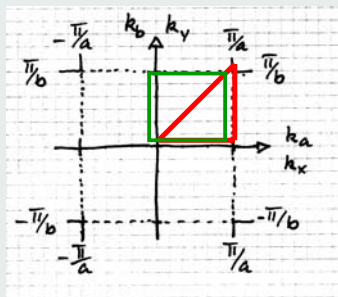
$$k=\frac{\pi}{a} \quad \psi_{\frac{\pi}{a}} = \sum_n e^{i\pi n} \chi_n = \sum_n (-1)^n \chi_n$$
$$= \chi_0 - \chi_1 + \chi_2 - \chi_3 + \dots$$


note that k has a reciprocal meaning
if k is small the wave of orbitals of the same sign modulation has a large length

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k-Vektors and Brillouin Zones

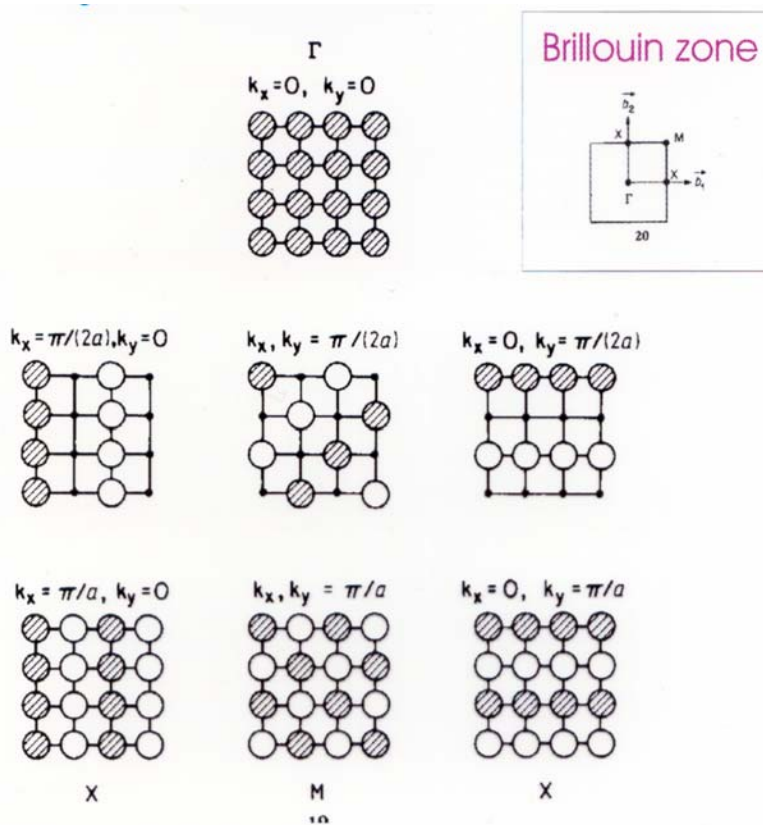


The Brillouin zone contains all the reciprocal vectors half way inbetween the first Bragg reflections

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2D LCAO combinations

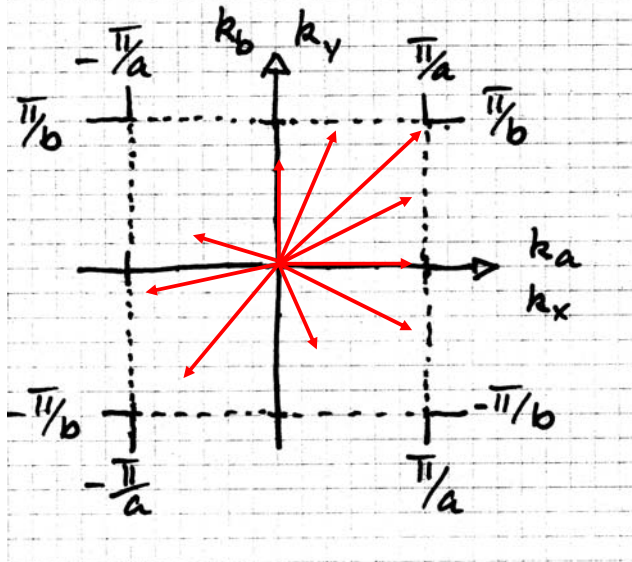


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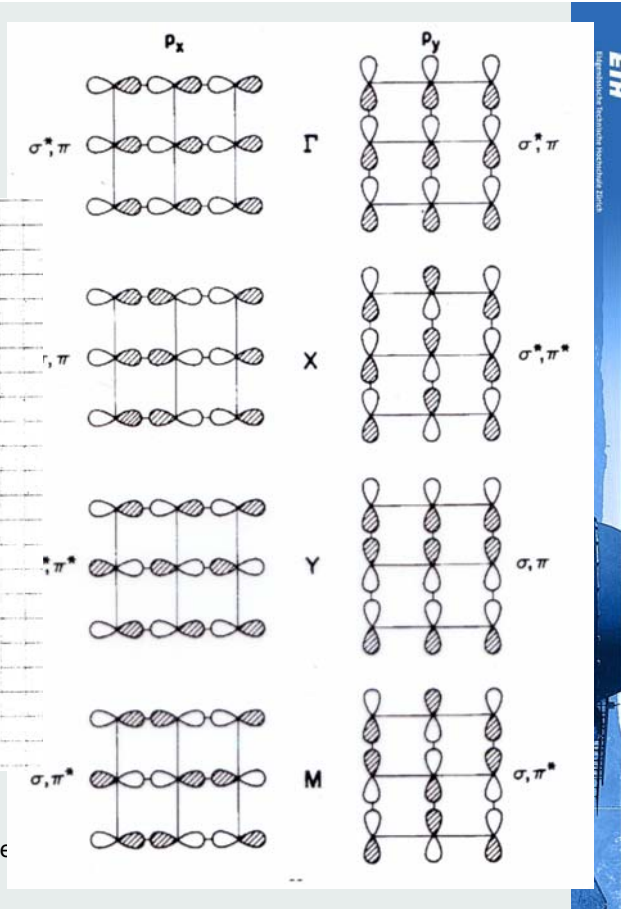
2D LCAO combinations

DUM



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Nanoch...



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Bandstructure of Silicon

R. NESPER, ETH ZÜRICH & COLLEGIUM HELVETICUM

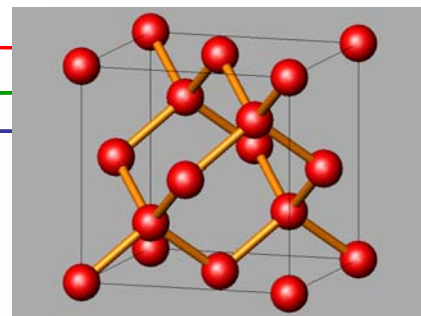
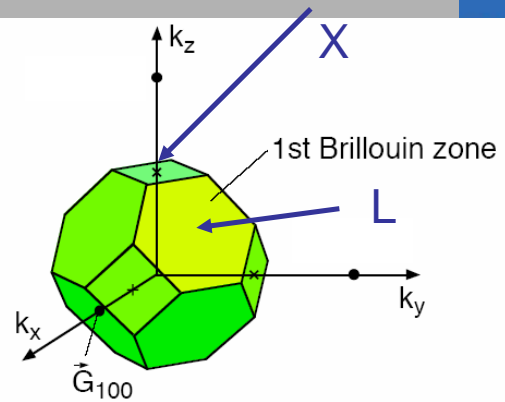
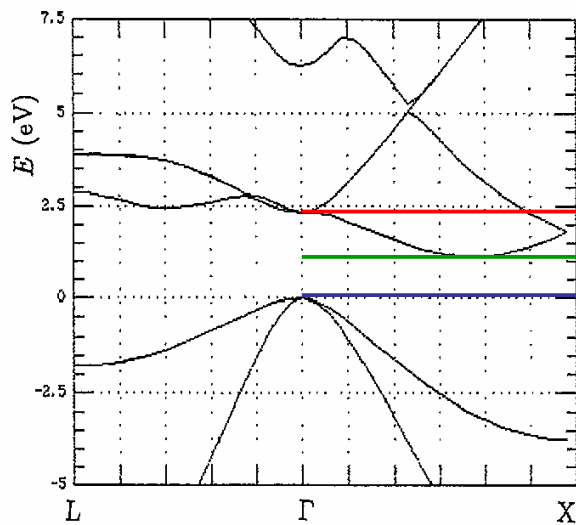


Figure 3. The band structure of silicon calculated with a (3s,3p,3d) basis set with complete configuration self-consistency.

Strength of Interaction and Band Width

the band width or the dispersion of the band depends on the strength of the interaction this is determined by the overlap integral and thus, is a function of the distance

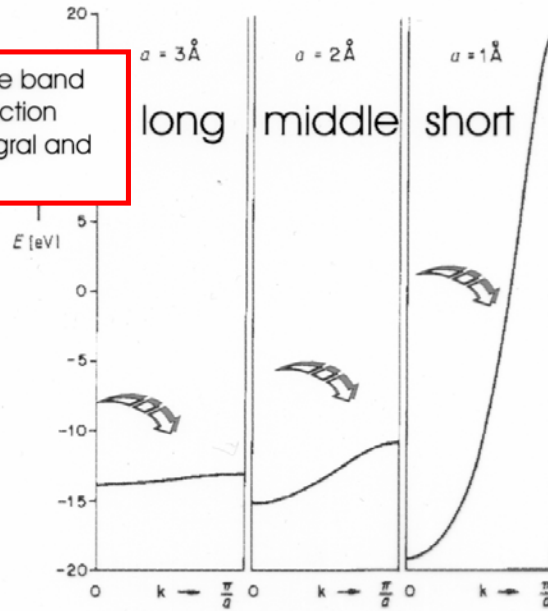


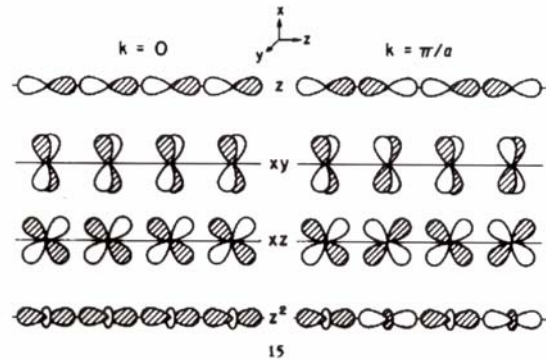
Figure 1 The band structure of a chain of hydrogen atoms spaced 3, 2, and 1 Å apart. The energy of an isolated H atom is -13.6 eV.

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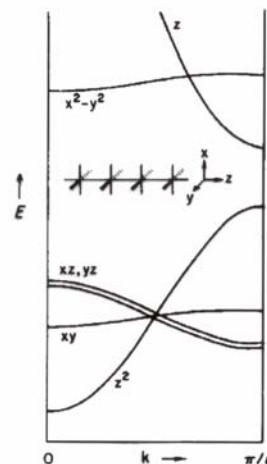
Nanochemistry UIO



Strength of Interaction and Band Width



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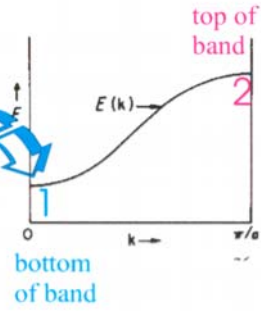


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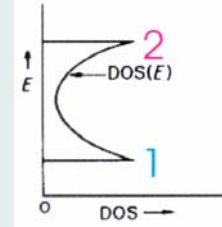
Solids

LCAO approach

$$\begin{aligned}
 k=0 \quad \psi_0 &= \sum_n e^{i0n} X_n = \sum_n X_n \\
 &= X_0 + X_1 + X_2 + X_3 + \dots \\
 k=\frac{\pi}{a} \quad \psi_{\frac{\pi}{a}} &= \sum_n e^{i\pi n} X_n = \sum_n (-1)^n X_n \\
 &= X_0 - X_1 + X_2 - X_3 + \dots
 \end{aligned}$$



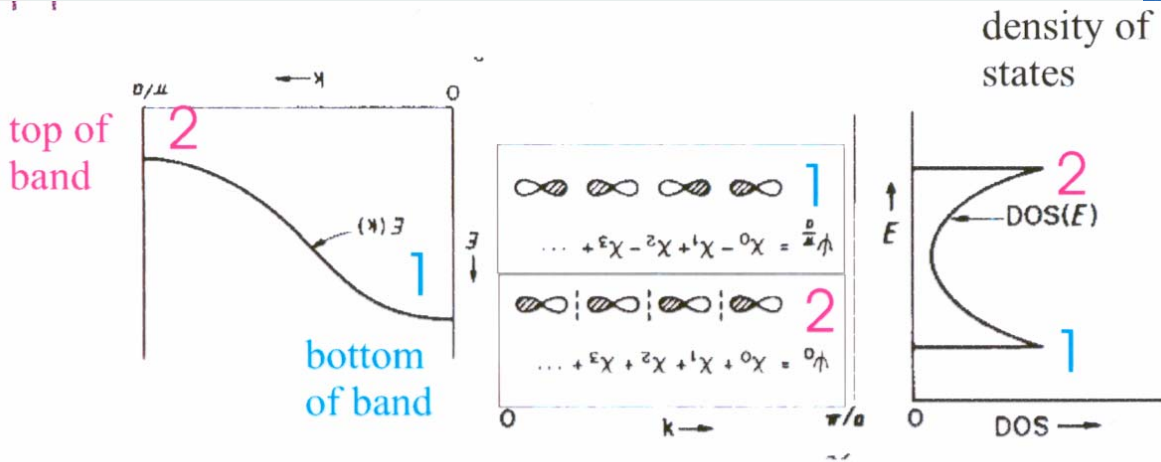
density of states



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Nanochemistry UIO

Solids

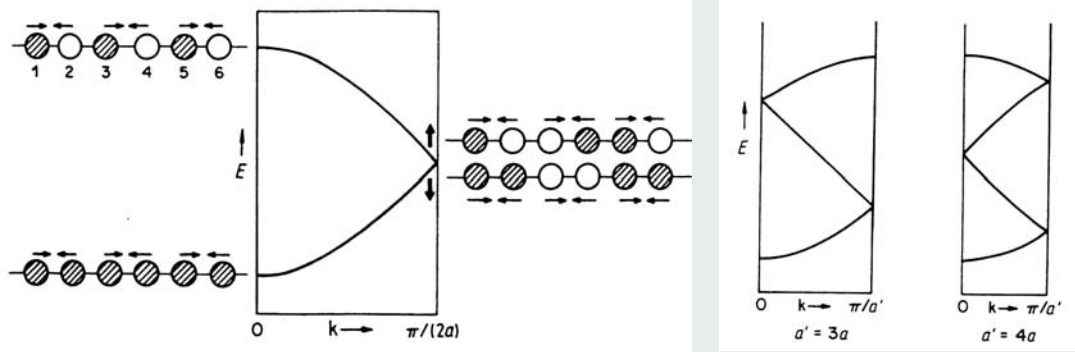
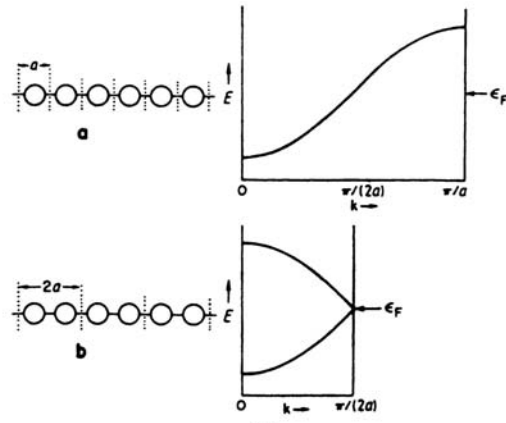


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Degeneracy and Distortions

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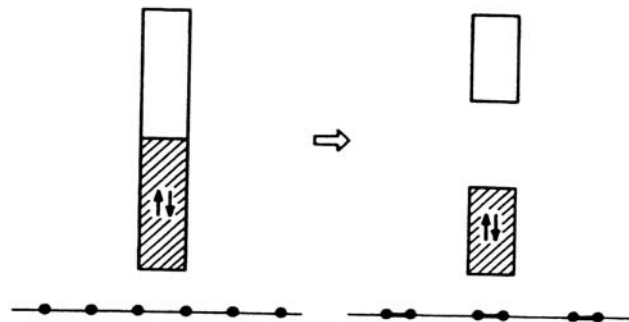
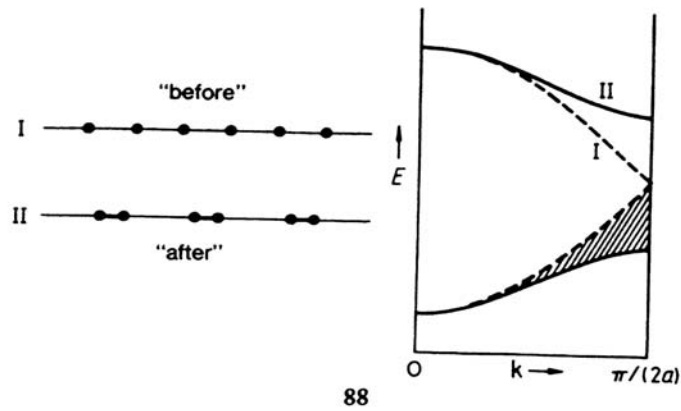
Nanochemistry UIO

Degeneracy and Distortions

R. NESPER, ETH ZÜRICH & COLLEGIUM HELVETICUM

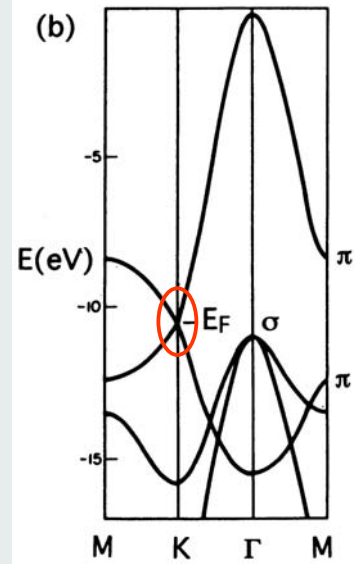
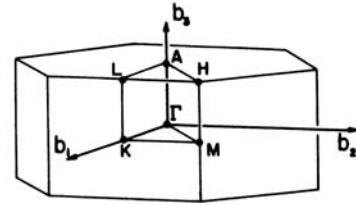
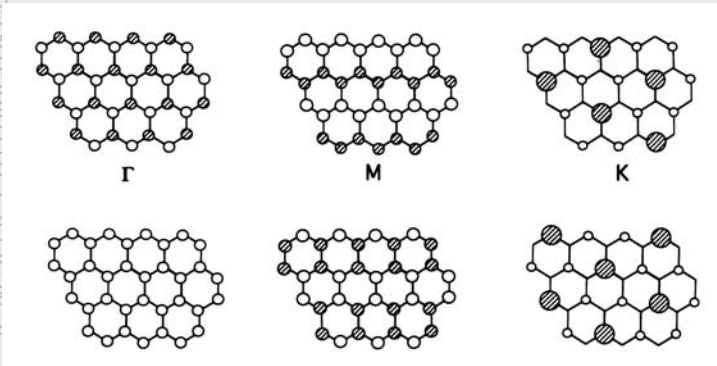
Peierls distortion in 1D systems

Cf. Jahn-Teller distortions



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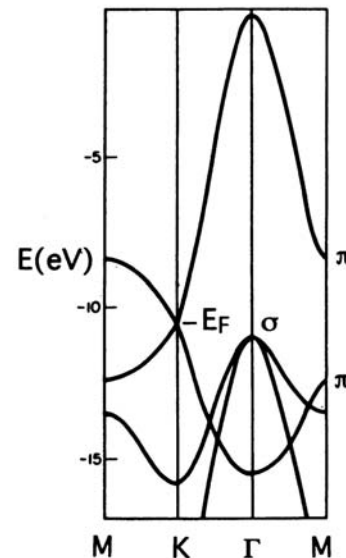
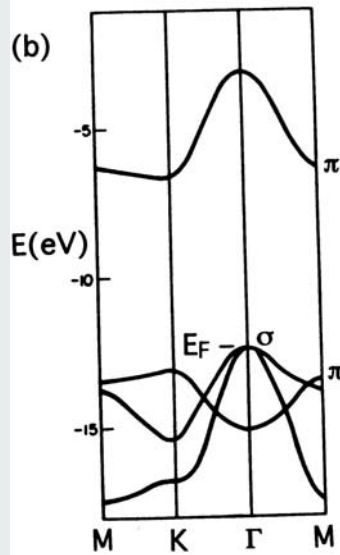
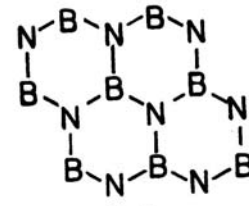
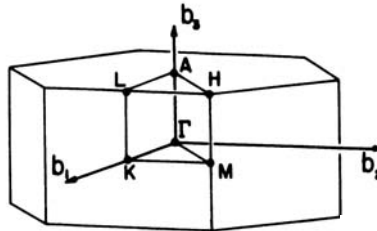
Graphite



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Bornitride - BN

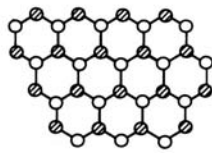
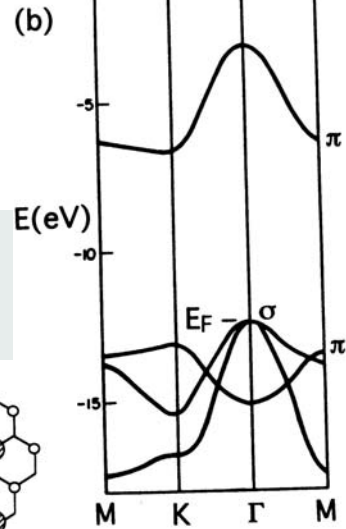
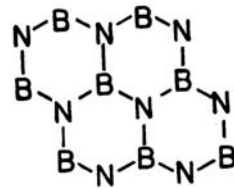
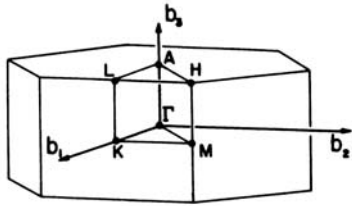


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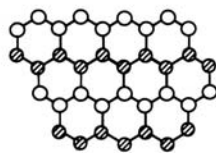
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Bornitride - BN

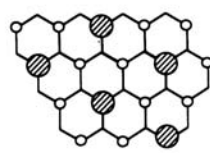
LEGIUM HELVETICUM



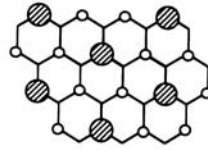
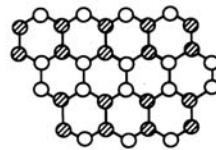
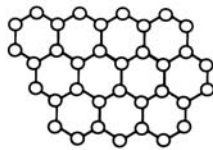
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and Technology

Density of States (DOS)

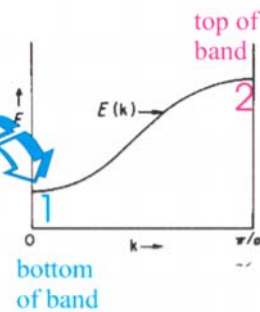
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LCAO approach

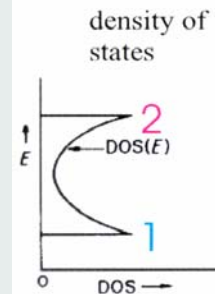
$$k=0 \quad \psi_0 = \sum_n e^{i0n} x_n = \sum_n x_n = x_0 + x_1 + x_2 + x_3 + \dots$$

$$k=\frac{\pi}{a} \quad \psi_{\frac{\pi}{a}} = \sum_n e^{i\pi n} x_n = \sum_n (-1)^n x_n = x_0 - x_1 + x_2 - x_3 + \dots$$

band



(DOS)



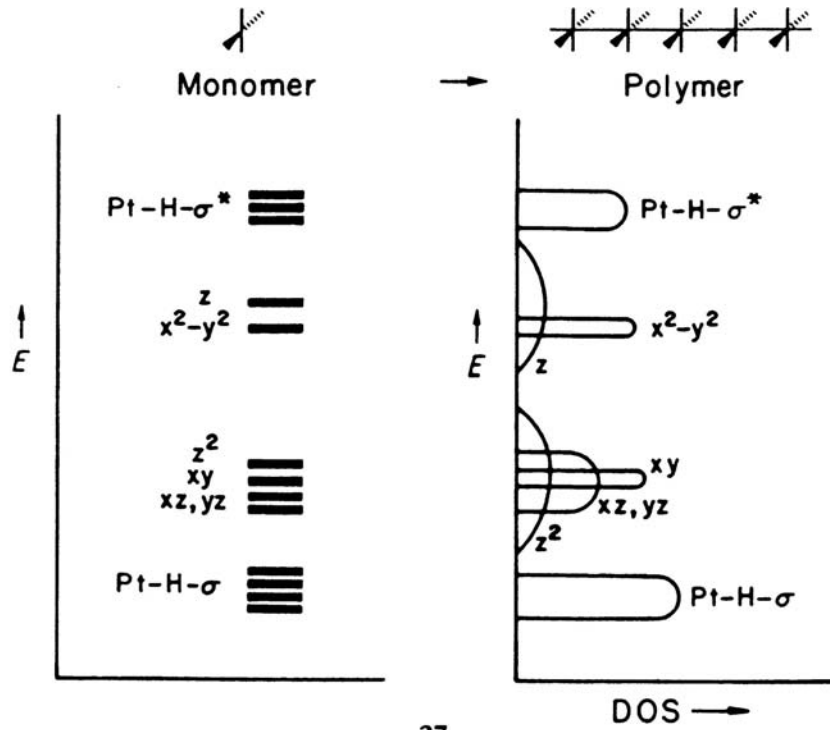
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DOS -PtH₄-Polymer

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27

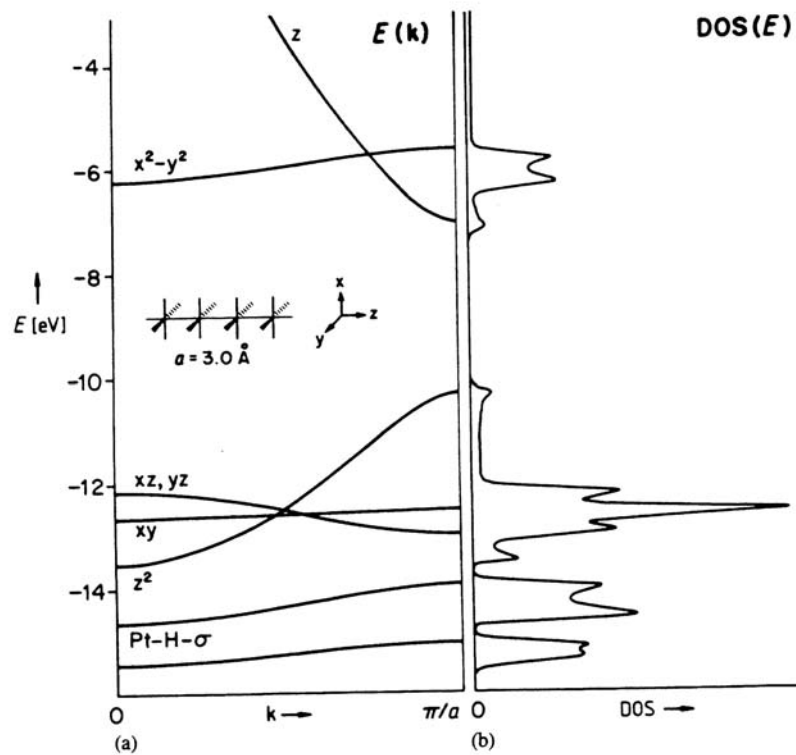
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DOS of PtH₄ Chain

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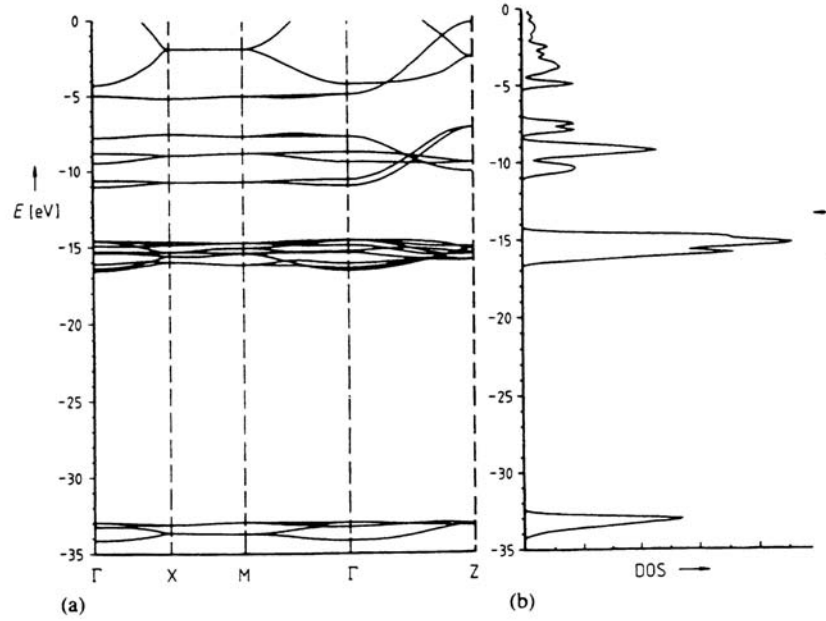


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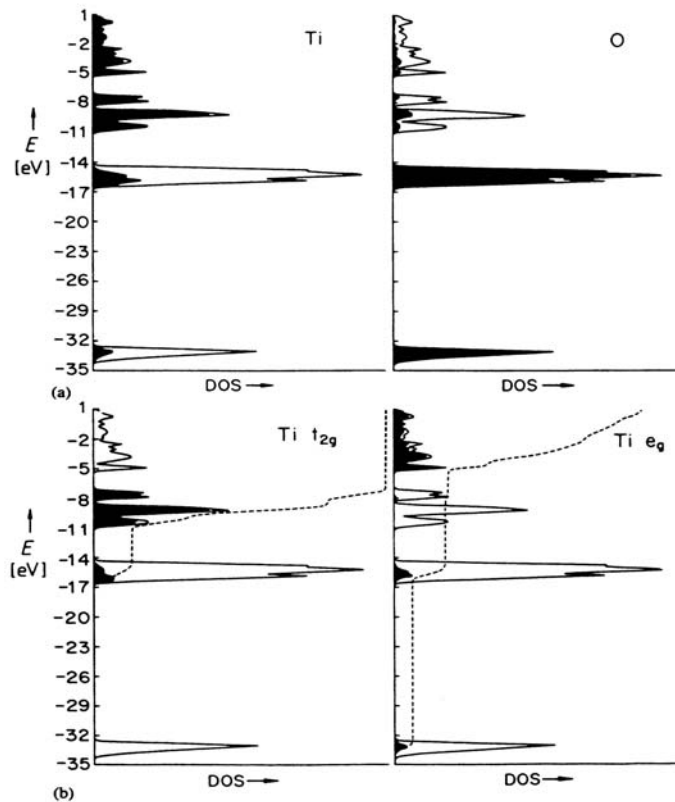
Band structure of ??



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Where are the electrons of ...?

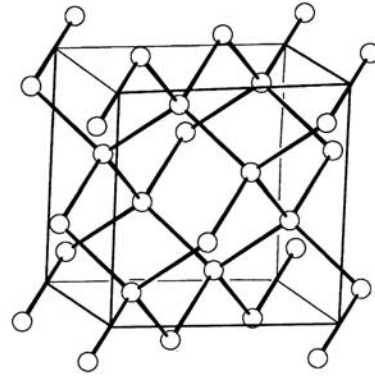
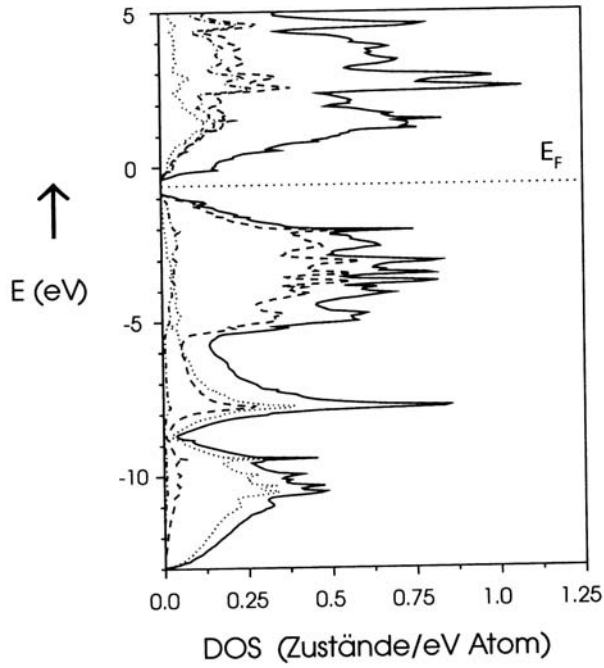


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Structure and DOS

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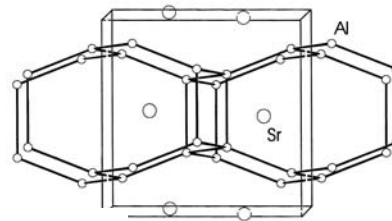
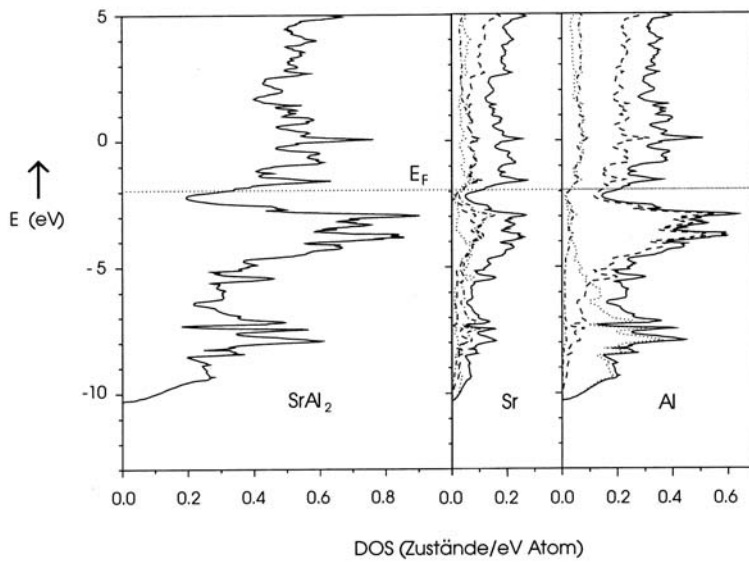


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Structure and DOS

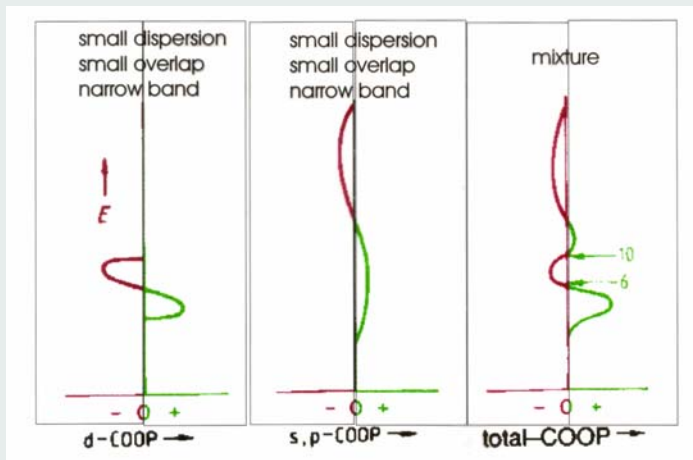
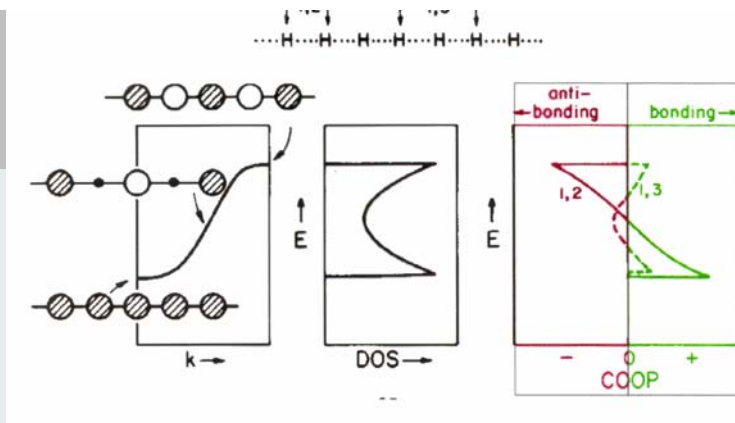
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Where are the Bonds?



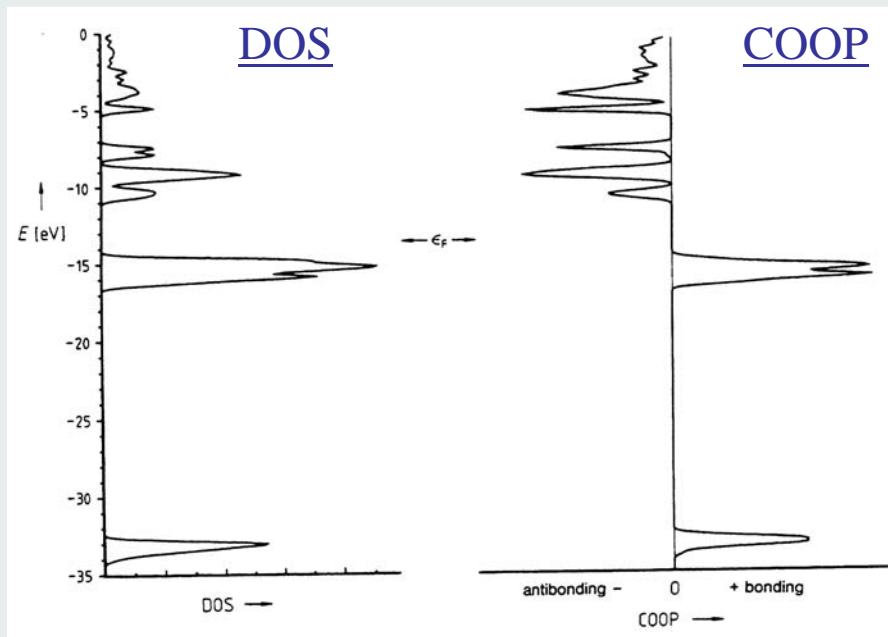
Choose a bond or a set of bonds and calculate overlap weighted DOS

$$c_i c_j S_{ij}$$

→ $S_{ij} < 0$ antibonding

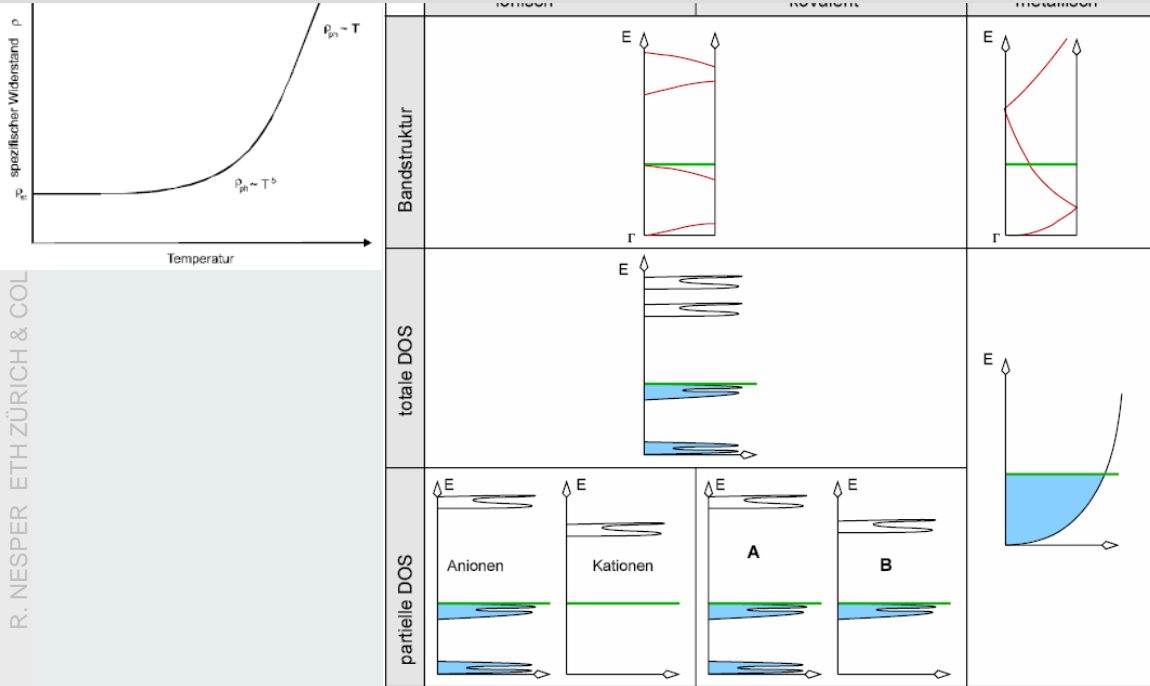
→ $S_{ij} > 0$ bonding

From DOS to Bonds



Metals, Semiconductors, Insulators

R. NESPER ETH ZÜRICH & COL

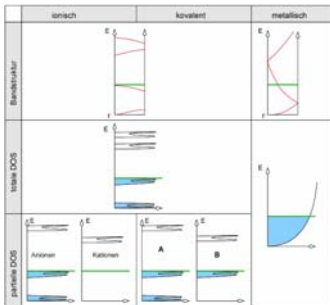


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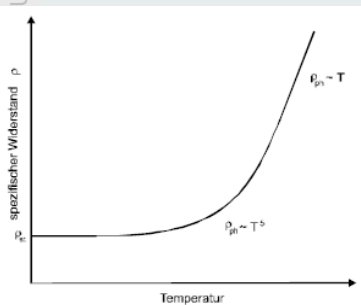
Nanochemistry UIO



Metals, Semiconductors, Insulators



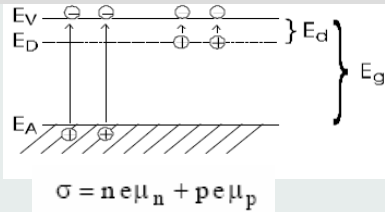
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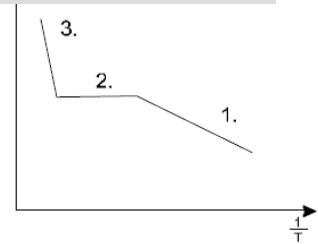
$T \ll \Theta_D$: $\rho_{ps} \propto T^5$ (Kleinwinkelstreuung)
 und
 $T \gg \Theta_D$: $\rho_{ps} \propto T$
 wobei Θ_D die Debye-Frequenz des Festkörpers ist.

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Nanochemistry UIO



$$\sigma = n e \mu_n + p e \mu_p$$



1. Störstellenreserve ($E_d \gg kT$):

Die thermische Energie reicht aus, um einige der Donatoratome zu ionisieren, d.h. um Elektronen aus den Donatorniveaus ins Leitungsband anzuregen.

$$n \propto e^{-\frac{E_d}{2kT}}$$

2. Störstellenschöpfung ($E_d \ll kT \ll E_g$):

Alle Donatoratome sind ionisiert, aber die thermische Energie reicht noch nicht aus, um Elektronen über die intrinsische Bandlücke anzuregen.

$$n = \text{const.}$$

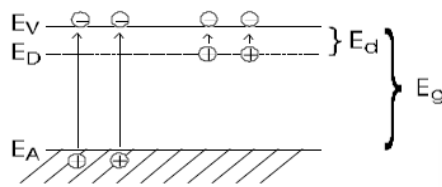
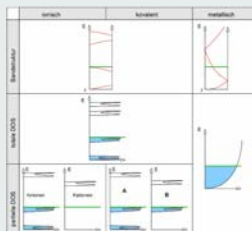
3. Eigenleitung ($E_g \ll kT$):

Die thermische Energie reicht nun aus, um intrinsische Ladungsträger zu erzeugen, d.h. Elektronen über die Bandlücke anzuregen. Gleichzeitig wird die Bedeutung der dotierten Ladungsträger immer kleiner.

$$n \propto e^{-\frac{E_g}{2kT}}$$

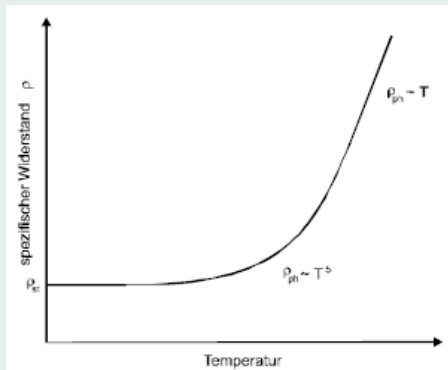


Metals, Semiconductors, Insulators



$$\sigma = ne\mu_n + pe\mu_p$$

Temperaturabhängigkeit der Leitfähigkeit setzt sich aus der der Beweglichkeit m und der Ladungsträgerkonzentration n (Elektronen) bzw. p (Löcher) zusammen



$$T \ll \Theta_D : \rho_{ph} \propto T^5 \quad (\text{Kleinwinkelstreuung})$$

und

$$T \gg \Theta_D : \rho_{ph} \propto T$$

wobei Θ_D die Debye-Frequenz des Festkörpers ist.

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Metals, Semiconductors, Insulators

I-VII compounds		II-VI compounds		III-V compounds	
LiF	11	ZnO	3.4	AlP	3.0
LiCl	9.5	ZnS	3.8	AlAs	2.3
NaF	11.5	ZnSe	2.8	AlSb	1.5
NaCl	8.5	ZnTe	2.4	GaP	2.3
NaBr	7.5	CdO	2.3	GaAs	1.4
KF	11	CdS	2.45	GaSb	0.7
KCl	8.5	CdSe	1.8	InP	1.3
KBr	7.5	CdTe	1.45	InAs	0.3
KI	5.8	PbS	0.37	InSb	0.2
		PbSe	0.27	β -SiC	2.2
		PbTe	0.33	α -SiC	3.1

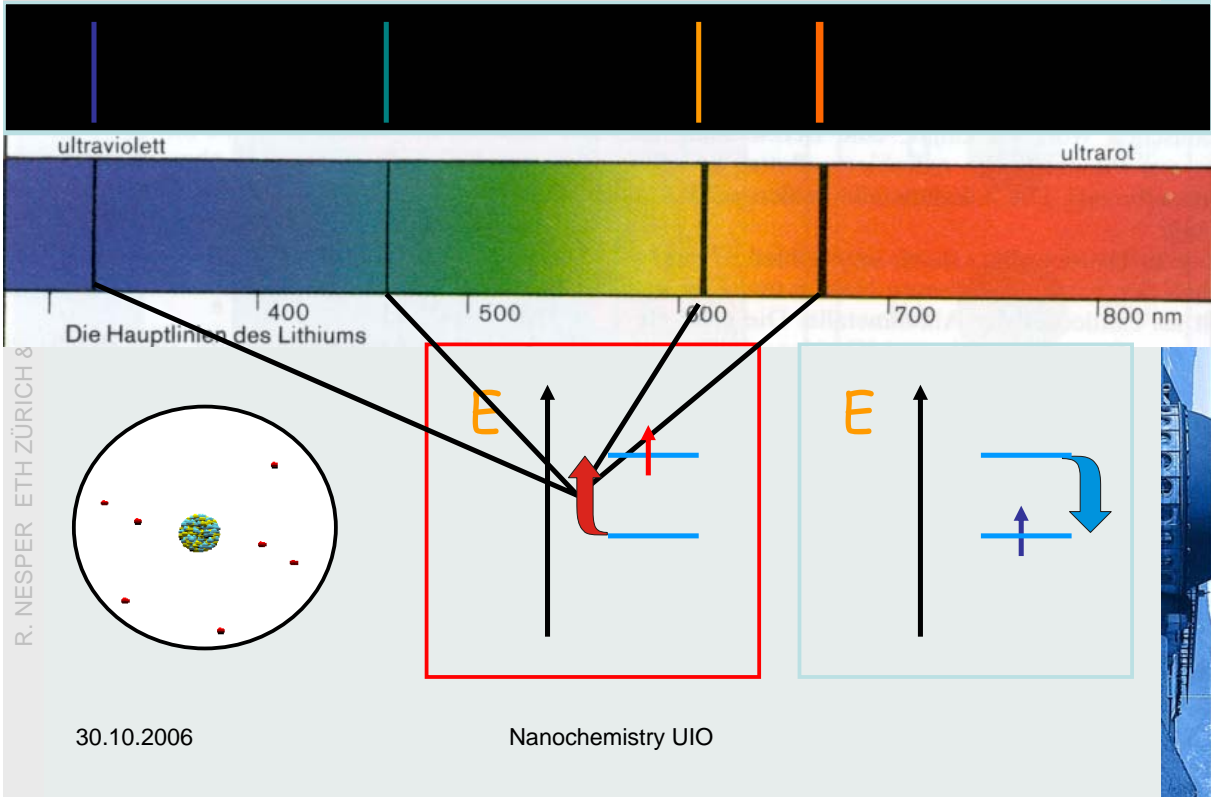
Some of these values, especially for the alkali halides, are only approximate.

Nitrides??

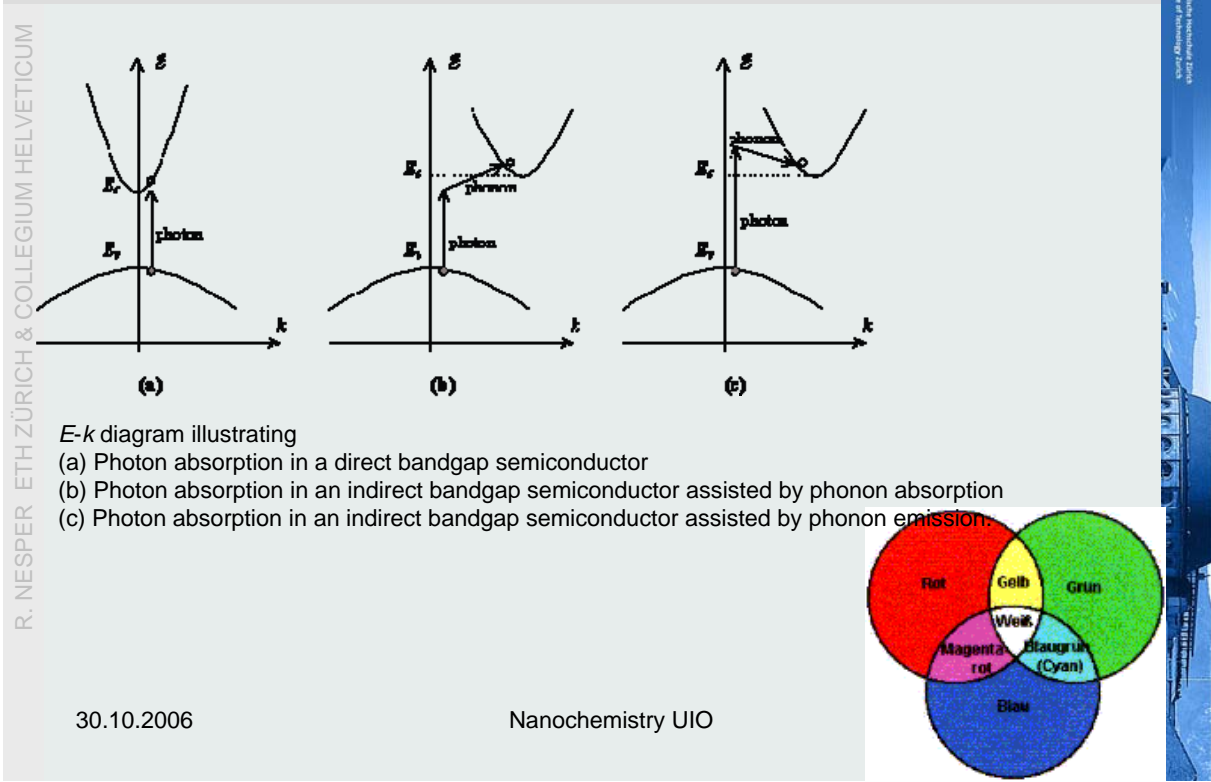
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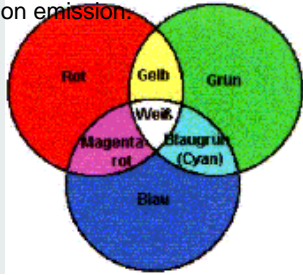
Optical Excitations and Colours



Light absorption and -emission



E-k diagram illustrating
 (a) Photon absorption in a direct bandgap semiconductor
 (b) Photon absorption in an indirect bandgap semiconductor assisted by phonon absorption
 (c) Photon absorption in an indirect bandgap semiconductor assisted by phonon emission.



Excitation and Charge Separation

R. NESPER, ETH ZÜRICH & COLLEGIUM HELVETICUM

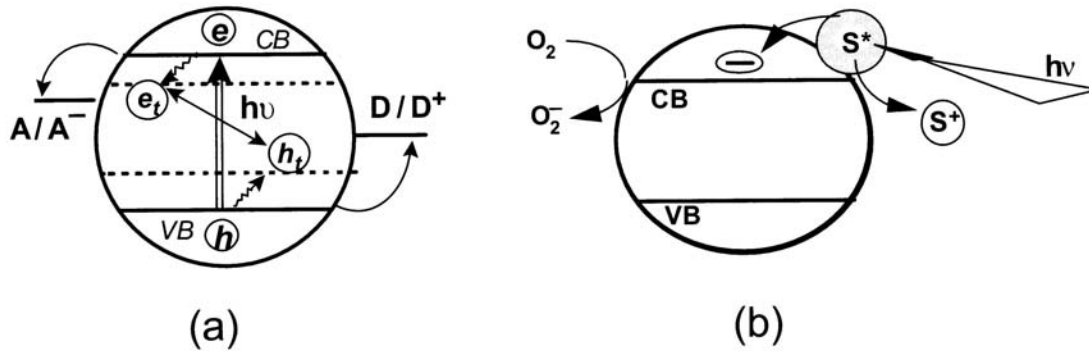


Fig. 19.1. Photoinduced charge transfer processes in semiconductor nanoclusters. (a) Under bandgap excitation and (b) sensitized charge injection by exciting adsorbed sensitizer

(S). CB and VB refer to the conduction and valence bands of the semiconductor and e_t and h_t refer to trapped electrons and holes, respectively.

Electron – hole separation for avoiding quenching or recombination of charges

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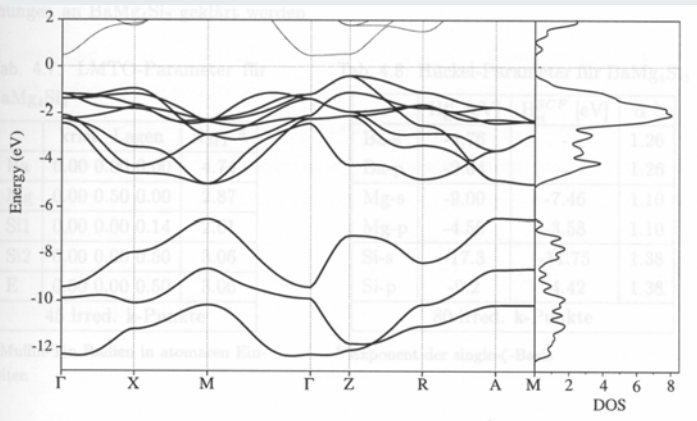
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Photoelectron spectra (ESCA)

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UPS: $E_{\text{rad}} = \text{UV radiation} \Rightarrow$

valence states (bonds, etc)



binding energy

Band structure

DOS

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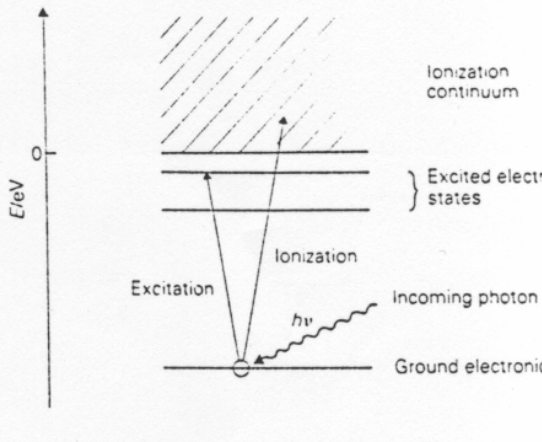
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Photoelectron spectra (ESCA)

$$E_{\text{kin}} (\text{electron}) = E_{\text{rad}} - E_{\text{bind}}$$

Surface method

2-3nm depth



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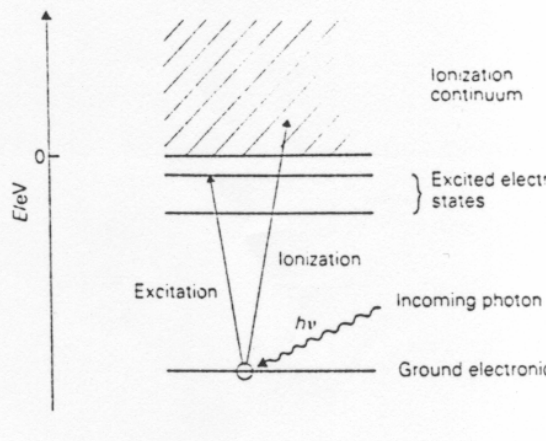
Photoelectron spectra (ESCA)

UPS: $E_{\text{rad}} = \text{UV radiation} \Rightarrow$

valence states (bonds, etc)

XPS: $E_{\text{rad}} = \text{X radiation} \Rightarrow$

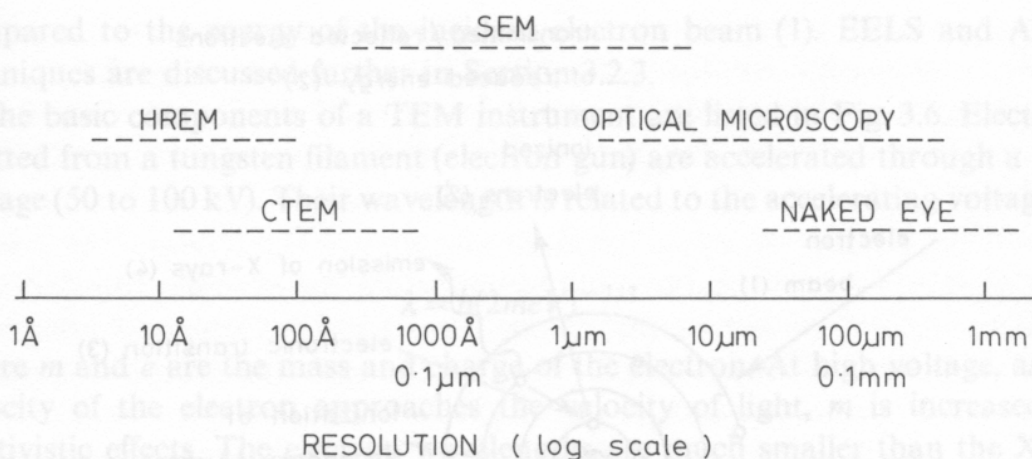
core states (oxidation states)



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Microscopy

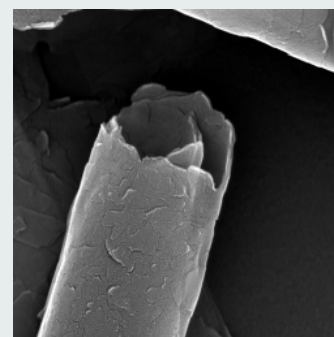
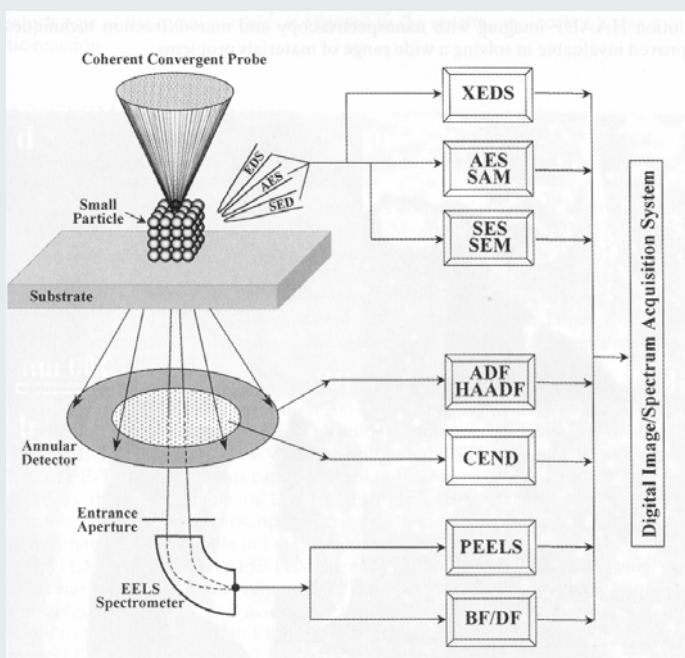


Scanning surface methods

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Scanning Electron Microscopy - SEM

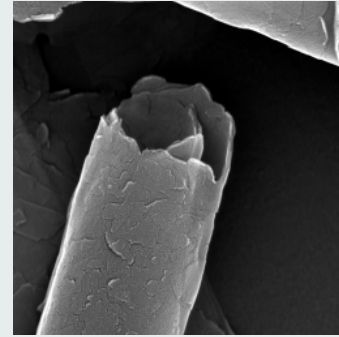
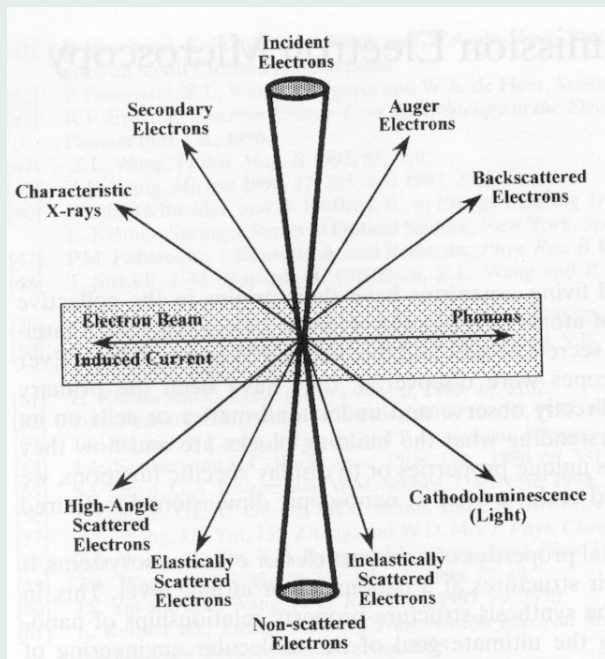


surface
analysis : 1 μ m

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Scanning Electron Microscopy



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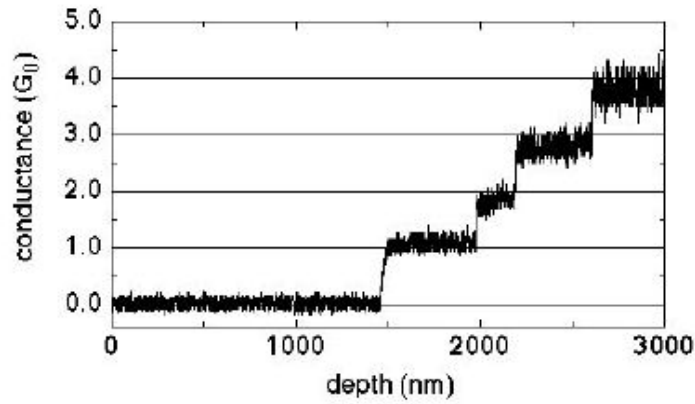
Scanning Probe Microscopies

1. Scanning tunneling Microscopy - STM
2. Atomic Force Microscopy - AFM
3. Magnetic Force Microscopy - MFM
4. Chemical Force Microscopies - CFM

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Scanning Probe Microscopies

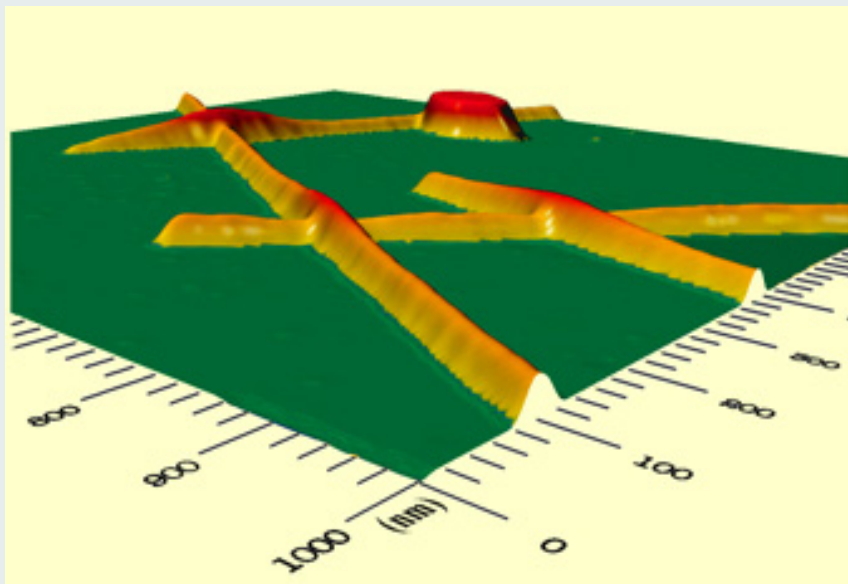


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Scanning Surface Microscopies



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Physical Effects and Methods

	Bond type	Electronic structure	Elemental analysis	Polycrystalline texture	Surface structure	Crystal defects	Local structure, CN, etc.	Crystal structure	Unit cell, space group	Amorphous or crystalline	Phase identification
X-ray diffraction	(✓)			(✓)	(✓)	(✓)	(✓)	✓	✓	✓	✓
Electron diffraction and microscopy			✓	✓	✓	✓		✓	✓	✓	✓
Neutron diffraction						✓		✓	✓	(✓)	(✓)
Optical microscopy				✓	(✓)	(✓)				✓	✓
IR spectroscopy	(✓)	(✓)		✓			✓				✓
UV, visual spectroscopy	✓	✓	(✓)			(✓)	✓				
NMR, ESR spectroscopy	(✓)	(✓)	(✓)			(✓)	✓				(✓)
Electron spectroscopy—ESCA, XPS, UPS, AES, EELS	✓	✓	✓		✓	(✓)	✓				
X-ray spectroscopy—XRF, AEFS, EXAFS	(✓)	(✓)	✓		✓	(✓)	✓				
Mössbauer spectroscopy	(✓)	(✓)					✓				

Physical Effects and Methods

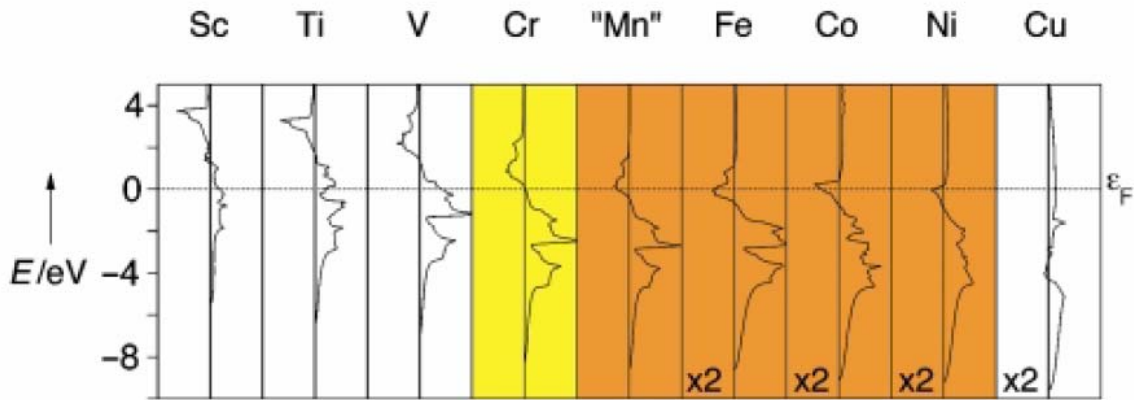
EPMA	Electron Probe Micro Analysis	Analyse der charakteristischen Röntgenstrahlung oder der Elektronenstrahlung ⇒ Elementaranalyse
EMMA	Electron Microscopy with Micro Analysis	
AEM	Analytical Electron Microscopy	
XRF	X-ray Fluorescence (charakteristische Röntgenstrahlung, Moseleysches Gesetz)	Analyse leichter Elemente
EDX	Energy Dispersive X-ray-Analysis	
EELS	Electron Energy Loss Spectroscopy	Analyse leichter Elemente
AES	Auger Electron Spectroscopy (Sekundärelektronen)	komplexe Spektren, bisher wenig untersucht
ESCA	Electron Spectroscopy for Chemical Analysis	$E_{\text{Einfall}}^{\nu} = E_{\text{Bind}}^{\text{Elektron}} + E_{\text{Kin.}}^{\text{Elektron}}$
XPS	X-ray Photoelectron Spectroscopy	$E_{\text{Kin.}}^{\text{Elektron}}$ wird gemessen
UPS	UV Photoelectron Spectroscopy	⇒ Elektronenstruktur von Feststoffen und Oberflächen
AEFS	Absorption Edge Fine Structure (XANES)	Oxidationszustände, lokale Umgebung
EXAFS	Extended X-ray Absorption Fine Structure	ausgewählter Atome
ESR	Electron Spin Resonance	Elektronenkonfiguration
EPR	Electron Paramagnetic Resonance	lokale Umgebung
ENDDR	Electron Nuclear Double Resonance	lokale Fehlstellen
Mößbauer	γ -Strahlen-Resonanz	Elektronenstruktur
STM	Scanning Tunnel Microscopy	magnetische Struktur
LEED	Low Energy Electron Diffraction	Oberflächenstrukturen

Magnetism

Angew. Chem. Int. Ed. 2000, 39, 1560–1585

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Angew. Chem. Int. Ed. 2000, 39, 1560–1585

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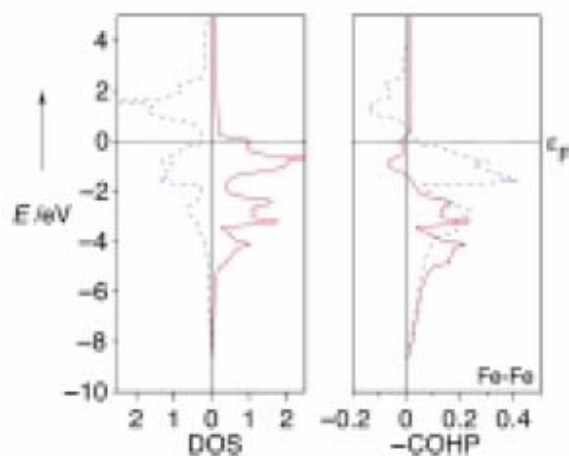


Figure 17. DOS and Fe-Fe COHP curves for ferromagnetic α -Fe. In each plot, the solid red/dashed blue line corresponds to the α/β spins. All curves have been shifted in energy so that ϵ_F , indicated with a horizontal dotted line, lies at 0.0 eV.

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